Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10611860	JENTSCH ET AL.
Examiner	Art Unit
Nguyen-Ba, Hoang-Vu A	2623

SEARCHED				
Class	Subclass	Date	Examine	

SEARCH NOTES			
Search Notes	Date	Examiner	
717/124-135; 712/226-227, 244; 714/34, 35, 38 updated previous text search	1/18/07	HAN	
Non Patent Literature Search Google	1/16/07	HAN	
Interference Search see search history printout	1/18/07	HAN .	

INTERFERENCE SEARCH					
Class	Subclass	Date	Examiner		
717	129, 125, 130, 131	1/18/07	HAN		
712	226, 227	1/18/07	HAN		
714	35	1/18/07	HAN		

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